US Patent & Trademark Office Patent Public Search | Text View

United States Patent Application Publication Kind Code Publication Date Inventor(s) 20250265006 A1 August 21, 2025 Cheng; Jen-Chuan

MEMORY STORAGE APPARATUS AND METHOD FOR OPERATING MEMORY STORAGE APPARATUS

Abstract

A memory storage apparatus, including a memory array and a controller circuit, is provided. The memory array is configured to store data. The controller circuit is coupled to the memory array. The controller circuit configured to receive a reset signal and a trigger signal. The controller circuit performs a reset operation according to the reset signal. The controller circuit maintains a power supply to the memory array according to the trigger signal during a reset period.

Inventors: Cheng; Jen-Chuan (Hsinchu, TW)

Applicant: Winbond Electronics Corp. (Taichung City, TW)

Family ID: 1000008393182

Assignee: Winbond Electronics Corp. (Taichung City, TW)

Appl. No.: 19/019543

Filed: January 14, 2025

Foreign Application Priority Data

TW 113105687 Feb. 19, 2024

Publication Classification

Int. Cl.: **G06F3/06** (20060101)

U.S. Cl.:

CPC **G06F3/0652** (20130101); **G06F3/0604** (20130101); **G06F3/0673** (20130101);

Background/Summary

CROSS-REFERENCE TO RELATED APPLICATION

[0001] This application claims the priority benefit of Taiwan application serial no. 113105687, filed on Feb. 19, 2024. The entirety of the above-mentioned patent application is hereby incorporated by reference herein and made a part of this specification.

TECHNICAL FIELD

[0002] This disclosure relates to an electronic device and a method for operating the same, and in particular to a memory storage apparatus and a method for operating the memory storage apparatus.

DESCRIPTION OF RELATED ART

[0003] Taking the volatile memory as an example, the data stored in the memory storage apparatus disappears during a power outage. For instance, a dynamic random-access memory (DRAM) cannot retain stored data after reset. However, in some applications, users may want to retain the stored data after the DRAM is reset to meet the requirement of a quick boot.

SUMMARY

[0004] This disclosure provides a memory storage apparatus and a method for operating the same, which can perform reset without power outage and maintain the accuracy of stored data after reset. [0005] The memory storage apparatus of this disclosure includes a memory array and a controller circuit. The memory array is configured to store data. The controller circuit is coupled to the memory array. The controller circuit is configured to receive a reset signal and a trigger signal. The controller circuit performs a reset operation according to the reset signal. The controller circuit maintains a power supply to the memory array according to the trigger signal during a reset period. [0006] The method for operating the memory storage apparatus of this disclosure includes: receiving a reset signal and a trigger signal; performing a reset operation according to the reset signal; and maintaining a power supply to a memory array according to the trigger signal during a reset period.

[0007] In order to make the above-mentioned features and advantages of this disclosure more obvious and easy to understand, embodiments are given below and described in detail with reference to the accompanying drawings.

Description

BRIEF DESCRIPTION OF THE DRAWINGS

[0008] FIG. **1** is a schematic block diagram of a memory storage apparatus of an embodiment of this disclosure.

[0009] FIG. 2 is a schematic waveform diagram of a trigger signal of the embodiment of FIG. 1.

[0010] FIG. **3** is a schematic waveform diagram of a trigger signal of another embodiment of this disclosure.

[0011] FIG. **4** is a schematic block diagram of a memory storage apparatus of an embodiment of this disclosure.

[0012] FIG. **5** is a schematic waveform diagram of a reset signal and a reference signal of an embodiment of this disclosure.

[0013] FIG. **6** is a flowchart of steps of a method for operating a memory storage apparatus of an embodiment of this disclosure.

[0014] FIG. 7 is a flowchart of steps of a method for operating a memory storage apparatus of another embodiment of this disclosure.

DETAILED DESCRIPTION OF DISCLOSED EMBODIMENTS

[0015] FIG. 1 is a schematic block diagram of a memory storage apparatus of an embodiment of this disclosure. Please refer to FIG. 1. A memory storage apparatus 100 includes a memory array 110 and a controller circuit 120. The controller circuit 120 is coupled to the memory array 110. The controller circuit 120 is configured to receive a reset signal S1 and a trigger signal S2. The controller circuit 120 performs a reset operation according to the reset signal S1. The controller circuit maintains a power supply to the memory array 110 according to the trigger signal S2 during a reset period.

[0016] In this embodiment, the memory storage apparatus **100** is, for example, a dynamic random-access memory (DRAM). Through maintaining the power supply to the memory array **110** during the reset period, the DRAM may perform reset without power outage and maintain the accuracy of internally stored data after reset.

[0017] FIG. 2 is a schematic waveform diagram of a trigger signal of the embodiment of FIG. 1. Please refer to FIG. 1 and FIG. 2. The trigger signal S2 of the embodiment of FIG. 1 may be a combination of external signals input to pins of the memory storage apparatus 100. The combination of the external signals includes signal type or voltage level. Specifically, the memory storage apparatus 100 is, for example, a DRAM chip. The external signals input to the pins of the DRAM chip include signals such as CS #, RAS #, CAS #, WE #, and CKE, wherein CS # is a chip selection signal, RAS # is a row address signal, CAS # is a column address signal, WE # is a write enable signal, and CKE is a reference signal. Through the different types of signal combinations and/or the high and low voltage levels, the controller circuit 120 may be triggered to determine whether to maintain the power supply to the memory array 110 during the reset period. [0018] In FIG. 2, the numbers, types, combinations, and voltage levels of the external signals are only used for demonstrative explanation and are not intended to limit this disclosure. In other embodiments, the external signals of different numbers, types, combinations, and voltage levels may also be used as the trigger signal S2.

[0019] FIG. 3 is a schematic waveform diagram of a trigger signal of another embodiment of this disclosure. Please refer to FIG. 1 and FIG. 3. The reset signal S1 of the embodiment of FIG. 1 may also be used as the trigger signal S2. The time length of the reset signal S1 may be used to determine whether to trigger the operation of the controller circuit 120 maintaining the power supply to the memory array 110 during the reset period. Specifically, in FIG. 3, reset signals S1 and S1' have a first level (low level) and a second level (high level). Compared with the reset signal S1', the time length of the first level of the reset signal S1 is longer. The reset signal S1 with the longer time length may be used as the trigger signal S2 to trigger the operation of maintaining the power supply. That is to say, the time length of the first level of the reset signal S1' may be used as a threshold t1', and the reset signal S1 with the time length greater than the threshold t1' may be used as the trigger signal S2.

[0020] On the contrary, in an embodiment, the reset signal S1' with the shorter time length may also be used as the trigger signal S2 to trigger the operation of maintaining the power supply. In this example, the time length of the first level of the reset signal S1 may be used as a threshold t1, and the reset signal S1' with the time length less than the threshold t1 may be used as the trigger signal S2.

[0021] FIG. **4** is a schematic block diagram of a memory storage apparatus of an embodiment of this disclosure. Please refer to FIG. **4**. A memory storage apparatus **400** of this embodiment further includes a power supply circuit **430**. The power supply circuit **430** is coupled to the memory array **110** and the controller circuit **120**. The power supply circuit **430** may be configured to receive an external power supply VDDO and generate a power supply VDD according to the external power supply VDDO. The power supply VDD may provide a power supply required for each circuit block inside the memory storage apparatus **400** to execute various operations.

[0022] The power supply circuit **430** provides the power supply VDD to the memory array **110** during the reset period, wherein the power supply circuit **430** may determine whether to maintain

the power supply to the memory array **110**, that is, to continuously provide the power supply VDD to the memory array **110** during the reset period according to a command of the controller circuit **120** to ensure that the memory array **110** can maintain the accuracy of the internally stored data after reset.

[0023] In an embodiment, the controller circuit 120 may include a reset circuit block and a self-refresh circuit block for executing the reset operation and a self-refresh operation, respectively. The reset circuit block and the self-refresh circuit block may be implemented as logic circuits on an integrated circuit. For instance, the following hardware may implement the related functions of the reset circuit block and the self-refresh circuit block: one or more controllers, microcontrollers, microprocessors, application-specific integrated circuits (ASIC), digital signal processors (DSP), field programmable gate arrays (FPGA), central processing units (CPU), and/or various logic blocks, modules, and circuits in other processing units. The related functions of the reset circuit block and the self-refresh circuit block may be implemented in hardware circuits such as various logic blocks, modules, and circuits in the integrated circuits through using a hardware description language (HDL) (for example, Verilog HDL or very high-speed integrated circuit (VHSIC) hardware description language (VHDL), or other suitable programming language. In addition, sufficient teachings, suggestions, and implementation instructions of the memory array 110, the controller circuit 120, and the power supply circuit 430 may be obtained by referring to common knowledge in the related art.

[0024] FIG. **5** is a schematic waveform diagram of a reset signal and a reference signal of an embodiment of this disclosure. Please refer to FIG. **1** and FIG. **5**. After the memory storage apparatus **100** is powered up, the controller circuit **120** executes the reset operation and the self-refresh operation according to the reset signal S**1** and the reference signal CKE.

[0025] Specifically, first, the controller circuit **120** performs the reset operation according to the reset signal **S1**, and maintains the power supply to the memory array **110** according to the trigger signal **S2** during a reset period **T1**. In this embodiment, the controller circuit **120** performs the self-refresh operation on the memory array **110** after the reset period **T1** is greater than a preset time length. For instance, the controller circuit **120** executes the self-refresh operation after executing the reset operation for more than 100 nanoseconds, so that the operation of the memory storage apparatus **100** complies with standard specifications.

[0026] Then, after executing the reset operation, the controller circuit **120** performs the self-refresh operation on the memory array **110** during a self-refresh period T**2**. In this embodiment, the controller circuit **120** stops the self-refresh operation according to the reference signal CKE. For instance, after the reference signal CKE remains at a low level for a period of time T**3**, the controller circuit **120** performs the self-refresh operation on the memory array **110** until the reference signal CKE changes from the low level to a high level (time t**2**). The memory storage apparatus **100** exits the self-refresh mode, and the controller circuit **120** stops performing the self-refresh operation on the memory array **110**.

[0027] FIG. **6** is a flowchart of steps of a method for operating a memory storage apparatus of an embodiment of this disclosure. Please refer to FIG. **1** and FIG. **6**. The method for operating the memory storage apparatus of this embodiment is at least applicable to the memory storage apparatus **100** of FIG. **1**, but this disclosure is not limited thereto.

[0028] Taking the memory storage apparatus **100** of FIG. **1** as an example, in Step S**100**, the controller circuit **120** receives the reset signal S**1** and the trigger signal S**2**. In Step S**110**, the controller circuit **120** performs the reset operation according to the reset signal S**1**. In Step S**120**, the controller circuit **120** maintains the power supply to the memory array **110** according to the trigger signal S**2** during the reset period T**1**.

[0029] In addition, sufficient teachings, suggestions, and implementation instructions of the method for operating the memory storage apparatus of this embodiment may be obtained from the description of the embodiments in FIG. **1** to FIG. **5**, and thus will not be described again.

[0030] FIG. 7 is a flowchart of steps of a method for operating a memory storage apparatus of another embodiment of this disclosure. Please refer to FIG. 1 and FIG. 7. The method for operating the memory storage apparatus of this embodiment is at least applicable to the memory storage apparatus **100** of FIG. **1**, but this disclosure is not limited thereto. [0031] In Step S**200**, a system sends the reset signal S**1** to the memory storage apparatus **100**, wherein the system is, for example, a processing circuit of a host system. In Step S210, the controller circuit **120** receives the reset signal S1. Next, in Step S220, the processing circuit judges whether the data stored in the memory array **110** needs to be maintained. [0032] If the data stored in the memory array 110 needs to be maintained, the method flow will enter Step S230. In Step S230, the system sends the reset signal S1 and the trigger signal S2 to the memory storage apparatus **100**. Next, in Step S**240**, the controller circuit **120** maintains the power supply to the memory array **110** according to the trigger signal S**2** during the reset period T**1**. In Step S250, the controller circuit 120 performs the self-refresh operation on the memory array 110 during the self-refresh period T2. In Step S260, the controller circuit 120 stops performing the selfrefresh operation on the memory array **110** according to the reference signal CKE. [0033] On the other hand, if the data stored in the memory array **110** does not need to be maintained, the method flow will enter Step S270. In Step S270, the controller circuit 120 executes the reset operation, but does not continuously supply power to the memory array 110. [0034] In summary, in the embodiments of this disclosure, the memory storage apparatus may perform reset without power outage, so the stored data may be retained after reset. In this way, the memory storage apparatus may be booted quickly, reducing interruption time and quickly restoring

Claims

1. A memory storage apparatus, comprising: a memory array, configured to store data; and a controller circuit, coupled to the memory array and configured to receive a reset signal and a trigger signal, wherein the controller circuit performs a reset operation according to the reset signal, and the controller circuit maintains a power supply to the memory array according to the trigger signal during a reset period.

to the original state, which make it less likely for the user to feel that an abnormality has occurred. [0035] Although the disclosure has been disclosed in the above embodiments, the embodiments are

not intended to limit the disclosure. Persons skilled in the art may make some changes and modifications without departing from the spirit and scope of the disclosure. Therefore, the

protection scope of the disclosure shall be defined by the appended claims.

- **2**. The memory storage apparatus according to claim 1, wherein the controller circuit performs a self-refresh operation on the memory array after executing the reset operation.
- **3**. The memory storage apparatus according to claim 2, wherein the controller circuit stops the self-refresh operation according to a reference signal.
- **4.** The memory storage apparatus according to claim 2, wherein the controller circuit performs the self-refresh operation on the memory array after the reset period is greater than a preset time length.
- **5.** The memory storage apparatus according to claim 1, wherein the trigger signal is a combination of an external signal input to a pin of the memory storage apparatus.
- **6**. The memory storage apparatus according to claim 5, wherein the combination of the external signal comprises signal type or voltage level.
- 7. The memory storage apparatus according to claim 1, wherein the reset signal is used as the trigger signal, and a time length of the reset signal is used to determine whether to trigger an operation of maintaining the power supply to the memory array during the reset period.
- **8.** The memory storage apparatus according to claim 1, further comprising: a power supply circuit, coupled to the memory array and the controller circuit, and configured to provide a power supply to

the memory array during the reset period, wherein the power supply circuit determines whether to maintain the power supply to the memory array during the reset period according to a command of the controller circuit.

- **9.** A method for operating a memory storage apparatus, wherein the memory storage apparatus comprises a memory array, the method for operating comprising: receiving a reset signal and a trigger signal; performing a reset operation according to the reset signal; and maintaining a power supply to the memory array according to the trigger signal during a reset period.
- **10**. The method for operating the memory storage apparatus according to claim 9, further comprising performing a self-refresh operation on the memory array after executing the reset operation.
- **11**. The method for operating the memory storage apparatus according to claim 10, further comprising stopping the self-refresh operation according to a reference signal.
- **12**. The method for operating the memory storage apparatus according to claim 10, wherein the self-refresh operation is performed on the memory array after the reset period is greater than a preset time length.
- **13**. The method for operating the memory storage apparatus according to claim 9, wherein the trigger signal is a combination of an external signal input to a pin of the memory storage apparatus.
- **14.** The method for operating the memory storage apparatus according to claim 13, wherein the combination of the external signal comprises signal type or voltage level.
- **15**. The method for operating the memory storage apparatus according to claim 9, wherein the reset signal is used as the trigger signal, and a time length of the reset signal is used to determine whether to trigger an operation of maintaining the power supply to the memory array during the reset period.